

### **47 CFR PART 15 SUBPART B**

# **TEST REPORT**

of

#### 850/1800/1900 Tri-band Handset

Model Name:

HG-E30

Trade Name:

Haier

Report No.:

SZ06120046E03

FCC ID:

SG70701HG-E30

prepared for

Qingdao Haier Telecom Co., Ltd.

No.1, Haier Road, Hi-tech Zone, Qingdao, 266101, P.R. China

Shenzhen Morla Communication Technology Co., Ltd.

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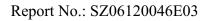








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#### **Test Result Certification** 1.

Equipment under Test: 850/1800/1900 Tri-band Handset

Trade Name: Haier Model Name: HG-E30

FCC ID: SG70701HG-E30

Applicant: Qingdao Haier Telecom Co., Ltd.

No.1, Haier Road, Hi-tech Zone, Qingdao, 266101, P.R. China

Report No.: SZ06120046E03

Manufacturer: Qingdao Haier Telecom Co., Ltd.

No.1, Haier Road, Hi-tech Zone, Qingdao, 266101, P.R. China

Test Standards: 47 CFR Part 15 Subpart B

Test Result: PASS

### \* We hereby certify that:

The equipment under test was tested by Shenzhen Morlab Communications Technology Co., Ltd. The test data, data evaluation, test procedures and equipment configurations shown in this report were made in accordance with the requirement of related FCC rules.

The test results of this report only apply for the tested sample equipment identified above. The test report shall be invalid without all the signatures of the test engineer, the reviewer and the approver.

Tested by:

Zhang Weimin

Reviewed by:

Yang Bo

Shu Luan

Approved by:

Dated:

Certification

2007.1.30



#### 2. General Information

### 2.1 Equipment under Test (EUT) Description

#### $EUT_1 / MS$ :

Model Name ..... HG-E30

Serial No. ....: ---

IMEI ...... 354415010001025

Hardware Version .....: V2.0

Software Version ...... MAUI.05C.W06.28

#### EUT<sub>2</sub> / Battery:

Description .....: Li-ion Battery

Model Name :: H11092
Trade Name :: Haier
Serial No. :: N/A

Manufacturer .....: Shenzhen XWODA Electronic Co. Ltd

Capacitance....: 630mAh
Rated Voltage...: 3.7V
Charge Limit Voltage...: 4.2V

#### EUT<sub>3</sub> / Charger:

Description .....: Travel Charger

Model Name ....: H21080
Trade Name ....: Haier
Serial No...: N/A

Manufacturer .....: NINGBO LISHUNDA ELECTRON CO.,LTD.

Rated Input .....:  $\sim 100-240V$ , 50/60Hz, 0.2A

Rated Output..... = 5.0V, 550mA

Length of DC Cable.....: 160cm

#### NOTE:

- 1. The EUT consists of EUT<sub>1</sub>/MS and normal options EUT<sub>2</sub>/Battery and EUT<sub>3</sub>/Charger.
- 2. For the detailed function of the EUT and test mode used, please refer to section 3.1.1.
- 3. For detailed features about the EUT, please see user manual supplied by applicant.



## 2.2 Test Standards and Results

The objective of the report is to perform EMC tests according to 47 CFR Part 15 Subpart B, and the EUT is classified as a Class B digital device:

No.	Identity	Document Title
1	47 CFR Part 15	Radio Frequency Devices
	(10-1-05 Edition)	

Test detailed items and the results are as below:

No.	Rules	Test Type	Result	Date of Test
1	§15.107	Conducted Emission	PASS	2007-1-18
2	§15.109	Radiated Emission	PASS	2007-1-18



### 2.3 Facilities and Accreditations

#### 2.3.1 Facilities

Shenzhen Electronic Product Quality Testing Center (Morlab) is a testing organization accredited by China National Accreditation Board for Laboratories (CNAL) according to ISO/IEC 17025. The accreditation certificate number is L1659.

All measurement facilities used to collect the measurement data are located at Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, P. R. China. The site was constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22, the FCC registration number is 741109.

### 2.3.2 Test Equipments

No.	Description	Specification	
1	System Simulator	Manufacturer:	Rohde&Schwarz
		Model No.:	CMU200
		Serial No.:	100448
2	System Simulator	Manufacturer:	Agilent
		Model No.:	E5515C
		Serial No.:	GB43130131
3	Receiver	Manufacturer:	Agilent
		Model No.:	E7405A
		Serial No.:	US44210471
4	LISN	Manufacturer:	Schwarzbeck
		Model No.:	NSLK8127
		Serial No.:	8127449
5	Telecommunication	Manufacturer:	European Antennas
	Antenna	Model No.:	PSA-45010R/356
		Serial No.:	403688-001
6	Trilogy Antenna	Manufacturer:	Schwarzbeck
		Model No.:	VULB 9163
		Serial No.:	9163-274
7	Anechoic Chamber	Manufacturer:	Albatross Projects GmbH
8	Shield Room	Manufacturer:	Albatross Projects GmbH

#### NOTE:

1. Equipments listed above have been calibrated and are in the period of validation.



# 2.3.3 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature:	20 - 25°C
Relative Humidity:	40 - 50%
Atmospheric Pressure:	86 - 106kPa



### 3. 47 CFR Part 15B Requirements

#### 3.1 General Information

#### 3.1.1 EUT Function and Test Mode

Mode 1: Call Mode:

The EUT configuration of the emission tests was MS + Battery + Charger.

Before the measurement, the lithium battery was completely discharge.

A communication link was established between the MS and a System Simulator (SS). The MS operated at mid ARFCN and maximum output power (level 5 for GSM 850 MHz and level 0 for PCS 1900 MHz).

Mode 2: Idle Mode:

The EUT configuration of the emission tests was MS + Battery + Charger.

Before the measurement, the lithium battery was completely discharge.

The EUT was synchronized to the BCCH, listening to the CCCH and able to respond to paging message. Periodic location updating was disabled.

Mode 3: USB Mode:

The EUT configuration of the emission tests was MS+ Notebook.

During the test, data was transmitted between MS and Notebook by the USB cable.

Mode 4: Camera Mode

The EUT configuration of the emission tests was MS + Battery + Charger.

During the test, the operating mode of the MS was camera review mode and picture display mode.

Mode 5: Mp3 Mode

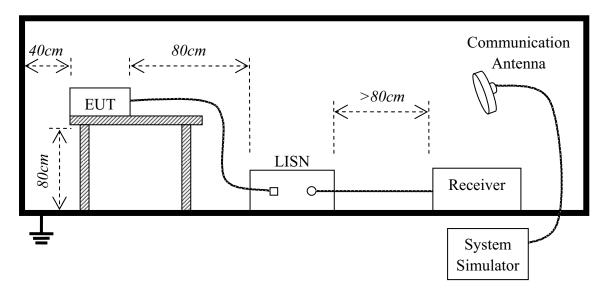
The EUT configuration of the emission tests was MS+ Headset.

During the test, the MS was playing the MP3 files.



### 3.1.2 Test Setup

#### 3.1.2.1 Conducted Emission Test

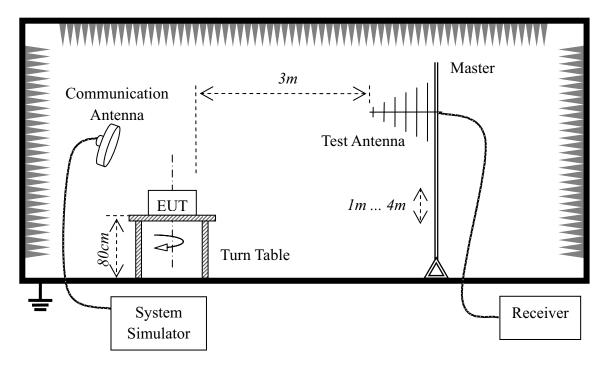


- 1. The test is performed in a Shield Room; the factors of the test system are calibrated to correct the reading.
- 2. The EUT is placed on a 0.8 meters high insulating table and keeps 0.4 meters away from the conducting wall of the Shield Room.
- 3. The EUT is connected to the power mains through a Line Impedance Stabilization Network (LISN). The LISN provides  $50\Omega/50\mu H$  of coupling impedance for the measuring instrument.





#### 3.1.2.2 Radiated Emission Test



- 1. The test is performed in a Semi-anechoic Chamber; the factors of the test system are calibrated to correct the reading.
- 2. The EUT is placed on a 0.8 meters high insulating table and keeps 3 meters away from the trilogy Test Antenna, which is mounted on the top of a variable-height antenna Master tower.



#### 3.2 Conducted Emission

#### 3.2.1 Requirement

According to FCC §15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a  $50\mu\text{H}/50\Omega$  line impedance stabilization network (LISN).

Eroguanov rango (MUz)	Conducted Limit (dBμV)			
Frequency range (MHz)	Quasi-peak	Average		
0.15 - 0.50	66 to 56	56 to 46		
0.50 - 5	56	46		
0.50 - 30	60	50		

#### NOTE:

- 1. The limit subjects to the Class B digital device.
- 2. The lower limit shall apply at the band edges.
- 3. The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

#### 3.2.2 Test Procedure

- 1. Perform test setup as described in section 3.1.2.1.
- 2. Each test mode in section 3.1.1 should be applied. At each test mode, the frequency range from 150 kHz to 30MHz is searched using the CISPR Quasi-Peak and/or the Average detector of the Receiver. If the emission levels measured with Quasi-Peak detector are lower than the Average Limit, it's not necessary to measure with Average detector.
- 3. The emission levels at both L phase and N phase should be tested.
- 4. Record the test result plot and distinct points.
- 5. In the test report show the worst test data.

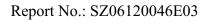


### 3.2.3 Test Result

**Test Mode: 1, 2,3,4** 

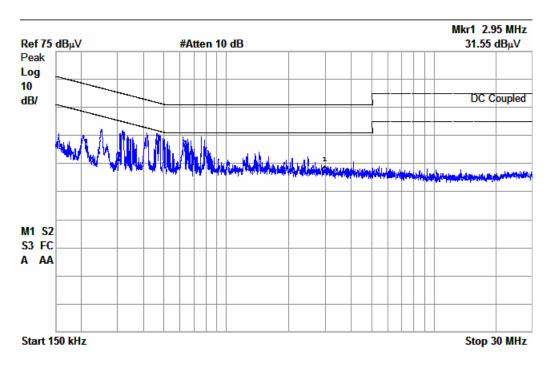
According the test data, the worst test configuration of the EUT was Mode 1, and its test data was showed as the follow:

No.	Frequency (MHz)	Emission Level (dBμV)			Limit (dBµV)		D = 0.14
		Quasi-Peak	Average	Phase (L/N)	Quasi-Peak	Average	Result
1	0.2039	40.51	32.04	N	< 63.4	< 53.4	PASS
2	0.3172	40.75	25.89	L	< 59.8	< 49.8	PASS
3	0.4801	31.38	24.39	N	< 56.3	< 46.3	PASS
4	0.6195	35.74	26.23	N	< 56.0	< 46.0	PASS
5	0.6556	34.87	24.93	L	< 56.0	< 46.0	PASS
6	0.7525	30.28	23.77	L	< 56.0	< 46.0	PASS

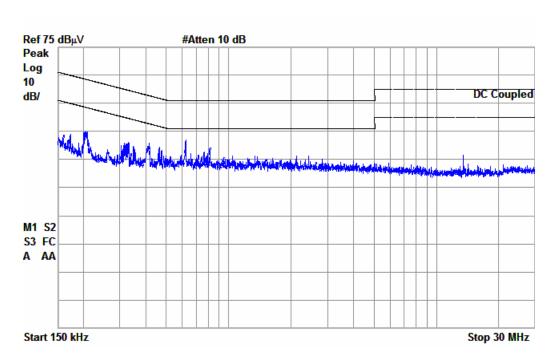




#### 1. Plot for L Phase:



### 2. Plot for N Phase:





#### 3.3 Radiated Emission

### 3.3.1 Requirement

According to FCC §15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Eraguanay ranga (MUz)	Field Strength			
Frequency range (MHz)	μV/m	dBμV/m		
30 - 88	100	40		
88 - 216	150	43.5		
216 - 960	200	46		
Above 960	500	54		

#### NOTE:

- 1. Field Strength  $(dB\mu V/m) = 20*log[Field Strength (\mu V/m)].$
- 2. In the emission tables above, the tighter limit applies at the band edges.

#### 3.3.2 Test Procedure

- 1. Perform test setup as described in section 3.1.2.2.
- 2. Each test mode in section 3.1.1 should be applied. At each test mode, the Turn Table turns from 0 degrees to 360 degrees to find the maximum reading; for the suspected points, the Test Antenna varies from 1 meter to 4 meters to determine the maximum value of the field strength.
- 3. The Receiver is set to Peak Detector function and specified bandwidth with maximum hold mode. If the emission level of the EUT in peak mode is 6dB lower than the limit specified, then testing could be stopped and the peak values would be reported; otherwise the emission less than 6dB margins would be retested one by one using the quasi-peak method.
- 4. The emission levels at both horizontal and vertical polarizations should be tested.
- 5. Record the test result plot and distinct points.
- 6. In the test report show the worst test data.



### 3.3.3 Test Result

Test Mode: 1, 2,3,4,5

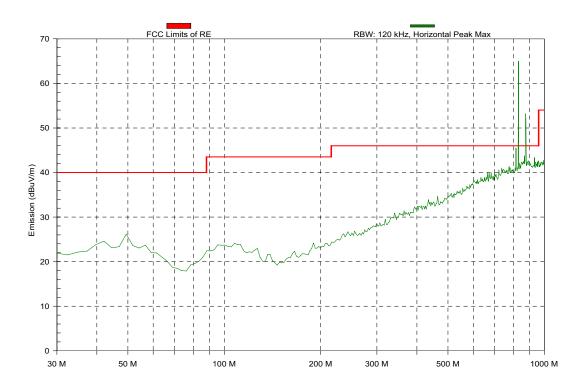
According the test data, the worst test configuration of the EUT was Mode 1, and its test data was showed as the follow:

No.	Frequency	Emission Level (dBμV/m)			Quasi-Peak	Result
NO.	(MHz)	Peak	Quasi-Peak	Antenna Polarization	Limit (dBµV/m)	Result
1	42.08	30.08		Horizontal	< 40	PASS
2	47.75	30.04		Horizontal	< 40	PASS
3	54.01	29.99		Horizontal	< 40	PASS
4	49.97	26.47		Vertical	< 40	PASS
5	145.78	22.14		Vertical	< 43.5	PASS
6	467.25	34.29		Vertical	< 46	PASS

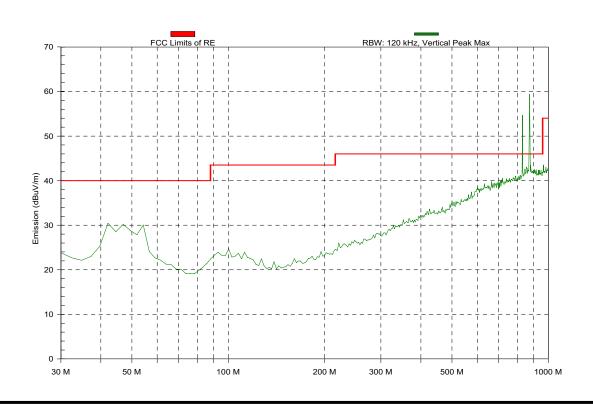


Following is the plots for emission measurement; please note that marked spikes with circle should be ignored because they are MS and SS carrier frequency.

1. Plot when Test Antenna at Horizontal Polarization:



2. Plot when Test Antenna at Vertical Polarization:





# I Photograph of the test setup

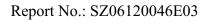
## 1. Mains Terminal Disturbance Voltage Measurement

Mode 1 &, Mode 2& Mode 4:



Mode 3:







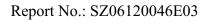
# 2. Radiated Field Strength Measurement

Mode 1, Mode 2 & Mode 4:



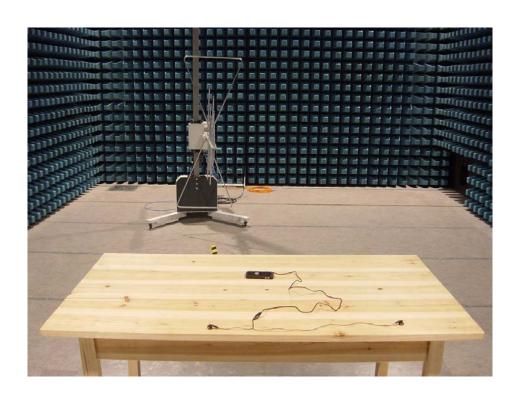
### Mode 3:

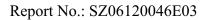






# Mode 5:





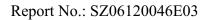


# II Photograph of the EUT

1. Appearance of the EUT





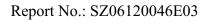




# 2. Appearance of the Adapter



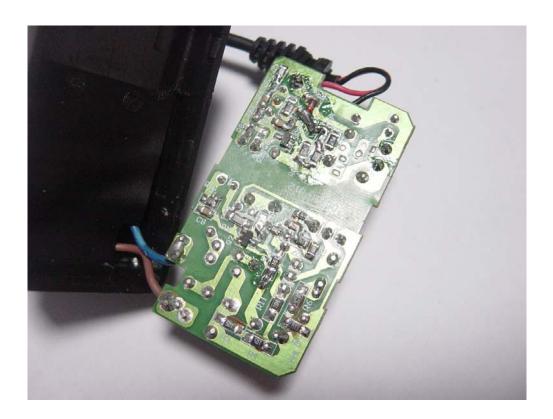


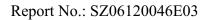




# 3. Inside of the Adapter





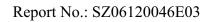




# 4. Inside of the EUT

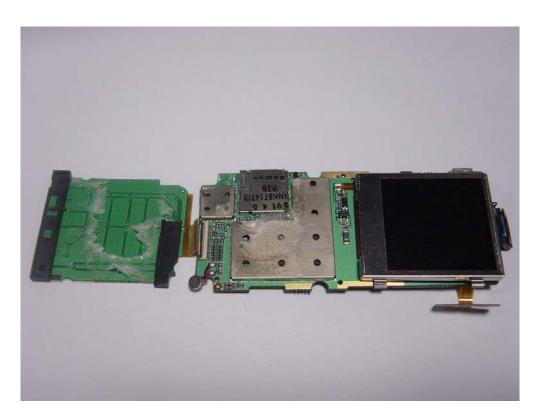


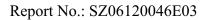








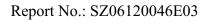














5. Appearance of the USB cable



# 6. Appearance of the headset

